

REVISIONS			
LTR	DESCRIPTION	DATE	APPROVED
A	Make limit changes to SNR and SINAD tests as specified under Table I. Add Total power dissipation test limits under Table I. Make condition limit change to tEN test under Table I. Add Mode of transportation and quantity column under paragraph 6.3. - ro	18-05-17	C. SAFFLE



Prepared in accordance with ASME Y14.24

Vendor item drawing

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REV STATUS OF PAGES	REV	A	A	A	A	A	A	A	A	A	A	A	A							
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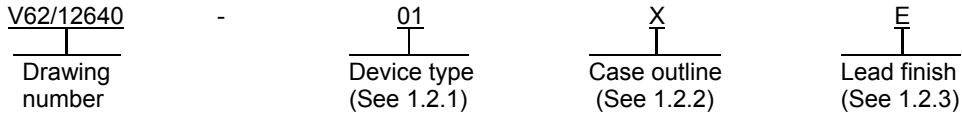
PMIC N/A	PREPARED BY Phu H. Nguyen						DLA LAND AND MARITIME COLUMBUS, OHIO 43218-3990 <a href="http://www.dla.mil/landandmaritime">http://www.dla.mil/landandmaritime</a>														
Original date of drawing YY-MM-DD  12-11-20	CHECKED BY Phu H. Nguyen						TITLE MICROCIRCUIT, DIGITAL-LINEAR, 16-BIT, 1 MSPS PuISAR ADC, MONOLITHIC SILICON														
	APPROVED BY Thomas M. Hess						DWG NO.  <b>V62/12640</b>														
	SIZE <b>A</b>	CODE IDENT. NO. <b>16236</b>																			
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DISTRIBUTION STATEMENT A. Approved for public release. Distribution is unlimited.

1. SCOPE

1.1 Scope. This drawing documents the general requirements of a high performance 16-bit, 1 million samples per second (MSPS) successive approximation register (PuLSAR) analog to digital converter (ADC) microcircuit, with an operating temperature range of -55°C to +125°C.

1.2 Vendor Item Drawing Administrative Control Number. The manufacturer's PIN is the item of identification. The vendor item drawing establishes an administrative control number for identifying the item on the engineering documentation:



1.2.1 Device type(s).

<u>Device type</u>	<u>Generic</u>	<u>Circuit function</u>
01	AD7980-EP	16-bit, 1 MSPS PuLSAR ADC

1.2.2 Case outline(s). The case outline(s) are as specified herein.

<u>Outline letter</u>	<u>Number of pins</u>	<u>JEDEC PUB 95</u>	<u>Package style</u>
X	10	JEDEC MO-187-BA	Mini small outline package

1.2.3 Lead finishes. The lead finishes are as specified below or other lead finishes as provided by the device manufacturer:

<u>Finish designator</u>	<u>Material</u>
A	Hot solder dip
B	Tin-lead plate
C	Gold plate
D	Palladium
E	Gold flash palladium
F	Tin-lead alloy (BGA/CGA)
Z	Other

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1.3 Absolute maximum ratings. 1/

Analog inputs: IN+, IN- to GND .....	-0.3 V to $V_{REF} + 0.3$ V or $\pm 130$ mA
Supply voltage:	
REF, $V_{IO}$ to GND .....	-0.3 V to +6 V
$V_{DD}$ to GND .....	-0.3 V to +3 V
$V_{DD}$ to $V_{IO}$ .....	+3 V to -6 V
Digital inputs to GND .....	-0.3 V to $V_{IO} + 0.3$ V
Digital outputs to GND .....	-0.3 V to $V_{IO} + 0.3$ V
Storage temperature range .....	-65°C to 150°C
Junction temperature .....	150°C
$\theta_{JA}$ Thermal impedance (Case outline X) .....	200°C/W
$\theta_{JC}$ Thermal impedance (Case outline X) .....	44°C/W
Lead temperature:	
Vapor phase (60 seconds) .....	215°C
Infrared (15 seconds) .....	220°C

1/ Stresses beyond those listed under “absolute maximum rating” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

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2. APPLICABLE DOCUMENTS

JEDEC Solid State Technology Association

JEDEC PUB 95 – Registered and Standard Outlines for Semiconductor Devices

(Applications for copies should be addressed to the JEDEC – Solid State Technology Association, 3103 North 10th Street, Suite 240–S, Arlington, VA 22201-2107.or online at <https://www.jedec.org>).

3. REQUIREMENTS

3.1 Marking. Parts shall be permanently and legibly marked with the manufacturer’s part number as shown in 6.3 herein and as follows:

- A. Manufacturer’s name, CAGE code, or logo
- B. Pin 1 identifier
- C. ESDS identification (optional)

3.2 Unit container. The unit container shall be marked with the manufacturer’s part number and with items A and C (if applicable) above.

3.3 Electrical characteristics. The maximum and recommended operating conditions and electrical performance characteristics are as specified in 1.3, 1.4, and table I herein.

3.4 Design, construction, and physical dimension. The design, construction, and physical dimensions are as specified herein.

3.5 Diagrams.

3.5.1 Case outline. The case outline shall be as shown in 1.2.2 and figure 1.

3.5.2 Terminal connections. The terminal connections shall be as shown in figure 2.

3.5.3 Load circuit for digital interface timing. The load circuit for digital interface timing shall be as shown in figure 3.

3.5.4 Voltage levels for timing. The voltage levels for timing shall be as shown in figure 4.

<p align="center"><b>DLA LAND AND MARITIME COLUMBUS, OHIO</b></p>	<p align="center">SIZE <b>A</b></p>	<p align="center">CODE IDENT NO. <b>16236</b></p>	<p align="center">DWG NO. <b>V62/12640</b></p>
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TABLE I. Electrical performance characteristics. 1/

Test	Symbol	Test conditions $V_{DD} = 2.5 \text{ V}$ , $V_{REF} = 5.0 \text{ V}$ $2.3 \text{ V} \leq V_{IO} \leq 5.5 \text{ V}$ $-55^\circ\text{C} \leq T_A \leq +125^\circ\text{C}$ unless otherwise noted	Limits			Unit
			Min	Typ	Max	
<b>Resolution</b>			16			Bits
<b>Analog input</b>						
Voltage range		IN+ - IN-	0		$V_{REF}$	V
Absolute input voltage		IN+	-0.1		$V_{REF} + 0.1$	V
		IN-	-0.1		+0.1	
Analog input CMRR		$f_{IN} = 100 \text{ kHz}$		60		dB
Leakage current @ 25°C		Acquisition phase		1		nA
<b>Accuracy</b>						
No missing codes			16			Bits
Differential linearity error		REF = 5 V	-0.9	$\pm 0.4$	+0.9	LSB <u>2/</u>
		REF = 2.5 V		$\pm 0.55$		
Integral linearity error		REF = 5 V	-1.5	$\pm 0.6$	+1.5	LSB <u>2/</u>
		REF = 2.5 V		$\pm 0.65$		
Transition noise		REF = 5 V		0.6		LSB <u>2/</u>
		REF = 2.5 V		1.0		
Gain error, $T_{MIN}$ to $T_{MAX}$ <u>3/</u>				$\pm 2$		LSB <u>2/</u>
Gain error temperature drift				$\pm 0.35$		ppm/°C
Zero error, $T_{MIN}$ to $T_{MAX}$ <u>3/</u>			-0.62	$\pm 0.08$	+0.62	mV
Zero temperature drift				0.54		ppm/°C
Power supply sensitivity		$V_{DD} = 2.5 \text{ V} \pm 5\%$		$\pm 0.1$		LSB <u>2/</u>
<b>Throughput</b>						
Conversion rate		$V_{IO} \geq 2.3 \text{ V}$ up to 85°C, $V_{IO} \geq 3.3 \text{ V}$ above 85°C up to 125°C	0		1	MSPS
Transient response		Full scale step			290	ns
<b>AC accuracy</b>						
Dynamic range		$V_{REF} = 5\text{V}$		92		dB <u>4/</u>
		$V_{REF} = 2.5\text{V}$		87		
Oversampled dynamic range		$f_0 = 10 \text{ kSPS}$		111		dB <u>4/</u>
Signal to Noise Ratio,	SNR	$f_{IN} = 10 \text{ kHz}$ , $V_{REF} = 5 \text{ V}$		91.5		dB <u>4/</u>
		$f_{IN} = 10 \text{ kHz}$ , $V_{REF} = 2.5 \text{ V}$		87		
Spurious Free Dynamic Range,	SFDR	$f_{IN} = 10 \text{ kHz}$		-110		dB <u>4/</u>
Total Harmonic Distortion,	THD	$f_{IN} = 10 \text{ kHz}$		-114		dB <u>4/</u>
Signal to (Noise +Distortion),	SINAD	$f_{IN} = 10 \text{ kHz}$ , $V_{REF} = 5 \text{ V}$		91		dB <u>4/</u>
		$f_{IN} = 10 \text{ kHz}$ , $V_{REF} = 2.5 \text{ V}$		86.5		

See footnote at end of table.

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TABLE I. Electrical performance characteristics - Continued. 1/

Test	Symbol	Test conditions $V_{DD} = 2.5\text{ V}$ , $V_{REF} = 5.0\text{ V}$ $2.3\text{ V} \leq V_{IO} \leq 5.5\text{ V}$ $-55^{\circ}\text{C} \leq T_A \leq +125^{\circ}\text{C}$ unless otherwise noted	Limits			Unit
			Min	Typ	Max	
<b>Reference</b>						
Voltage range			2.4		5.1	V
Load current		1 MSPS, REF = 5 V		330		$\mu\text{A}$
<b>Sampling dynamics</b>						
-3 dB input bandwidth				10		MHz
Aperture delay		$V_{DD} = 2.5\text{ V}$		2.0		ns
<b>Digital inputs</b>						
Logic level	$V_{IL}$	$V_{IO} > 3\text{ V}$	-0.3		$0.3 \times V_{IO}$	V
	$V_{IH}$	$V_{IO} > 3\text{ V}$	$0.7 \times V_{IO}$		$V_{IO} + 0.3$	V
	$V_{IL}$	$V_{IO} \leq 3\text{ V}$	-0.3		$0.1 \times V_{IO}$	V
	$V_{IH}$	$V_{IO} \leq 3\text{ V}$	$0.9 \times V_{IO}$		$V_{IO} + 0.3$	V
	$I_{IL}$		-1		+1	$\mu\text{A}$
	$I_{IH}$		-1		+1	$\mu\text{A}$
<b>Digital outputs</b>						
Data format		Serial 16 bits straight binary				
Pipeline delay		Conversion results available immediately after completed conversion				
	$V_{OL}$	$I_{SINK} = 500\ \mu\text{A}$			0.4	V
	$V_{OH}$	$I_{SOURCE} = -500\ \mu\text{A}$	$V_{IO} - 0.3$			V
<b>Power supply</b>						
$V_{DD}$			2.375	2.5	2.625	V
$V_{IO}$		Specified performance	2.3		5.5	V
$V_{IO}$ range			1.8		5.5	V
Standby current <u>5/</u> <u>6/</u>		$V_{DD}$ and $V_{IO} = 2.5\text{ V}$ , $T_A = 25^{\circ}\text{C}$		0.35		nA
Power dissipation		$V_{DD} = 2.625\text{ V}$ , $V_{REF} = 5\text{ V}$ , $V_{IO} = 3\text{ V}$				
Total	Total	10 kSPS throughput		70		$\mu\text{W}$
		1 MSPS throughput		7.0	10	mW
VDD only				4		mW
REF only				1.7		mW
VIO only				1.3		mW
Energy per conversion				7.0		nJ/sample
<b>Temperature range</b>						
Specified performance		$T_{MIN}$ to $T_{MAX}$	-55		+125	$^{\circ}\text{C}$

See footnote at end of table.

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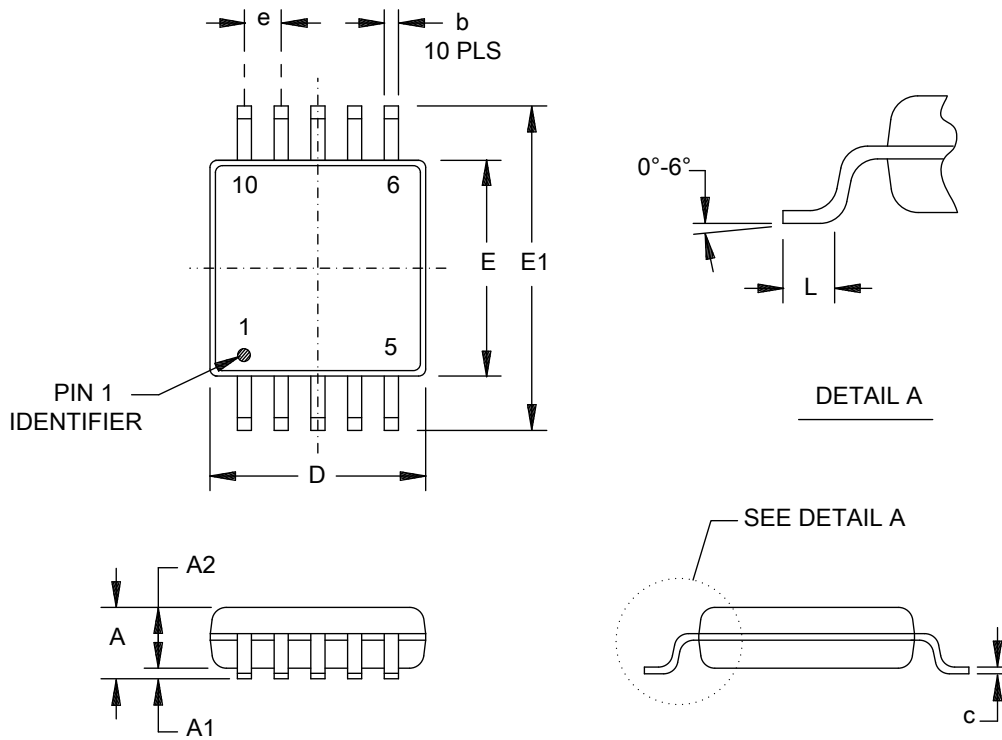
TABLE I. Electrical performance characteristics - Continued. 1/

Test	Symbol	Test conditions 2.37 V ≤ V <sub>DD</sub> ≤ 2.63 V 3.3 V ≤ V <sub>IO</sub> ≤ 5.5 V -55°C ≤ T <sub>A</sub> ≤ +125°C unless otherwise noted	Limits			Unit
			Min	Typ	Max	
<b>Timing specifications</b> (see FIGURE 2 and 3 for load condition)						
Conversion time: CNV rising edge to data available	t <sub>CONV</sub>		500		710	ns
Acquisition time	t <sub>ACQ</sub>		290			ns
Time between conversions	t <sub>CYC</sub>		1000			ns
CNV pulse width (CS Mode)	t <sub>CNVH</sub>		10			ns
SCK period (CS Mode)	t <sub>SCK</sub>	V <sub>IO</sub> above 4.5 V	10.5			ns
		V <sub>IO</sub> above 3 V	12			
		V <sub>IO</sub> above 2.7 V	13			
		V <sub>IO</sub> above 2.3 V	15			
SCK period (chain mode)	t <sub>SCK</sub>	V <sub>IO</sub> above 4.5 V	11.5			ns
		V <sub>IO</sub> above 3 V	13			
		V <sub>IO</sub> above 2.7 V	14			
		V <sub>IO</sub> above 2.3 V	16			
SCK low time	t <sub>SCKL</sub>		4.5			ns
SCK high time	t <sub>SCKH</sub>		4.5			ns
SCK falling edge to data remains valid	t <sub>HSDO</sub>		3			ns
SCK falling edge to data valid delay	t <sub>DSO</sub>	V <sub>IO</sub> above 4.5 V			9.5	ns
		V <sub>IO</sub> above 3 V			11	
		V <sub>IO</sub> above 2.7 V			12	
		V <sub>IO</sub> above 2.3 V			14	
CNV or SDI low to SDO D15 MSB valid (CS Mode)	t <sub>EN</sub>	V <sub>IO</sub> above 3 V			10	ns
		V <sub>IO</sub> above 2.3 V			15	
CNV or SDI high or last SCK falling edge to SDO high impedance (CS Mode)	t <sub>DIS</sub>				20	ns
SDI valid setup time from CNV rising edge	t <sub>SSDICNV</sub>		5			ns
SDI valid hold time from CNV rising edge (CS Mode)	t <sub>HSDICNV</sub>		2			ns
SDI valid hold time from CNV rising edge (Chain Mode)	t <sub>HSDICNV</sub>		0			ns
SCK valid setup time from CNV rising edge (Chain mode)	t <sub>SSCKCNV</sub>		5			ns
SCK valid hold time from CNV rising edge (Chain Mode)	t <sub>HCKCNV</sub>		5			ns
SDI valid setup time from SCK falling edge (Chain mode)	t <sub>SSDISCK</sub>		2			ns
SDI valid hold time from SCK falling edge (Chain Mode)	t <sub>HSDISCK</sub>		3			ns
SDI high to SDO high (Chain mode with Busy Indicator)	t <sub>DSDOSDI</sub>				15	ns

- 1/ Testing and other quality control techniques are used to the extent deemed necessary to assure product performance over the specified temperature range. Product may not necessarily be tested across the full temperature range and all parameters may not necessarily be tested. In the absence of specific parametric testing, product performance is assured by characterization and/or design.
- 2/ LSB means least significant bit. With the 5 V input range, 1 LSB is 76.3 μV.
- 3/ These specifications include full temperature range variation, but not the error contribution from the external reference.
- 4/ All specifications in dB are referred to a full scale input FSR. Tested with an input signal at 0.5 dB below full scale, unless otherwise specified.
- 5/ With all digital inputs forced to V<sub>IO</sub> or GND as required.
- 6/ During the acquisition phase.

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Case X



Dimensions					
Symbol	Millimeters		Symbol	Millimeters	
	Min	Max		Min	Max
A		1.10	D/E	2.90	3.10
A1	0.05	0.15	E1	4.65	5.15
A2	0.75	0.95	e	0.50 BSC	
b	0.15	0.30	L	0.40	0.70
c	0.13	0.23			

**NOTES:**

1. All linear dimensions are in millimeters.
2. Falls within JEDEC MO-187-BA.

FIGURE 1. Case outline.

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Case outline X			
Terminal number	Terminal symbol	Terminal number	Terminal symbol
1	REF	10	VIO
2	V <sub>DD</sub>	9	SDI
3	IN+	8	SCK
4	IN-	7	SDO
5	GND	6	CNV

FIGURE 2. Terminal connections.

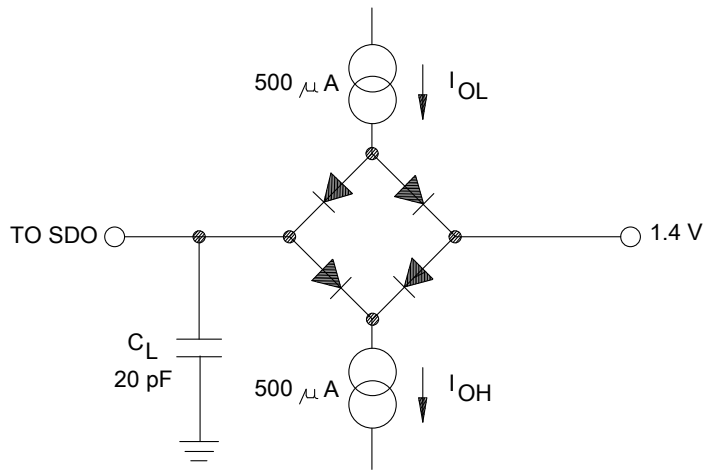
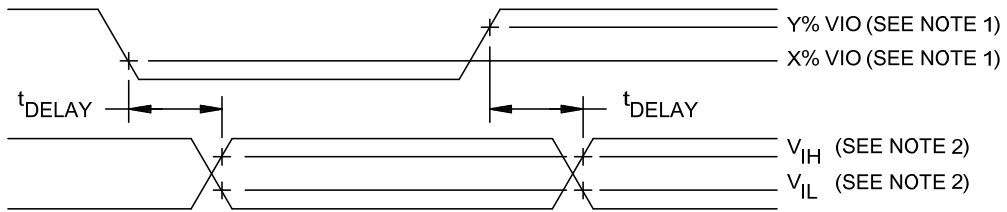


FIGURE 3. Load circuit for digital interface timing.



NOTES:

1. For  $V_{IO} \leq 3.0$  V,  $X = 90$  and  $Y = 10$ ; For  $V_{IO} > 3.0$  V  $X = 70$  and  $Y = 30$ .
2. Minimum  $V_{IH}$  and maximum  $V_{IL}$  used. See Digital Inputs specifications in table I.

FIGURE 4. Voltage levels for timing.

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4. VERIFICATION

4.1 Product assurance requirements. The manufacturer is responsible for performing all inspection and test requirements as indicated in their internal documentation. Such procedures should include proper handling of electrostatic sensitive devices, classification, packaging, and labeling of moisture sensitive devices, as applicable.

5. PREPARATION FOR DELIVERY

5.1 Packaging. Preservation, packaging, labeling, and marking shall be in accordance with the manufacturer's standard commercial practices for electrostatic discharge sensitive devices.

6. NOTES

6.1 ESDS. Devices are electrostatic discharge sensitive and are classified as ESDS class 1 minimum.

6.2 Configuration control. The data contained herein is based on the salient characteristics of the device manufacturer's data book. The device manufacturer reserves the right to make changes without notice. This drawing will be modified as changes are provided.

6.3 Suggested source(s) of supply. Identification of the suggested source(s) of supply herein is not to be construed as a guarantee of present or continued availability as a source of supply for the item. DLA Land and Maritime maintains an online database of all current sources of supply at <https://landandmaritimeapps.dla.mil/programs/smcr/>.

Vendor item drawing administrative control number <u>1/</u>	Device manufacturer CAGE code	Mode of transportation and quantity	Vendor part number
V62/12640-01XE	24355	Reel, 1,000 units	AD7980SRMZ-EP-RL7 <u>2/</u>

1/ The vendor item drawing establishes an administrative control number for identifying the item on the engineering documentation.

2/ Z = RoHS compliant part.

CAGE code

24355

Source of supply

Analog Devices  
 Route 1 Industrial Park  
 P.O. Box 9106  
 Norwood, MA 02062  
 Point of contact: Raheen Business Park  
 Limerick, Ireland

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